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Application/Control No.	Applicant(s)/Patent unde Reexamination	er
10/764,422	SREENIVAS ET AL.	
Examiner	Art Unit	
Shih-Chao Chen	2821	

SEARCHED				
Class	Subclass	Date	Examiner	
343	700MS, 793, 795, 824, 829, 846	8/2/2005	CHEN	
343	853, 893	8/2/2005	CHEN	
343	727	8/2/2005	CHEN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (See attached printout).	8/2/2005	CHEN
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